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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO. CONFIRMATION NO.		
10/706,963	11/14/2003	Vassoudevane Lebonheur	P-6119-US	7768	
27130 7.	590 05/05/2005		EXAMINER		
EITAN, PEARL, LATZER & COHEN ZEDEK LLP 10 ROCKEFELLER PLAZA, SUITE 1001			QUACH, TUAN N		
NEW YORK,	•	1001	ART UNIT	PAPER NUMBER	
ŕ			2826	_	
			DATE MAILED: 05/05/200	5	

Please find below and/or attached an Office communication concerning this application or proceeding.

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Applicant(s)
EBONHEUR ET AL.
Art Unit
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respondence address
FROM
filed
ill be considered timely. mailing date of this communication. 35 U.S.C. § 133). ay reduce any
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I to by the Examiner.
7 CFR 1.85(a).
eted to. See 37 CFR 1.121(d).
Out of 101111 1 10-102.
*
d) or (f).
No in this National Stage

Office Action Summary

Application No.	Applicant(s)		
10/706,963	LEBONHEUR ET	AL.	
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Tuan Quach	2826		
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	Tuan Quach	2826					
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) days will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	nely filed s will be considered time the mailing date of this c D (35 U.S.C.§ 133).	ly. ommunication.				
Status							
1) Responsive to communication(s) filed on							
·—	action is non-final.						
3)☐ Since this application is in condition for allowar	•		e merits is				
closed in accordance with the practice under <i>E</i>	x parte Quayle, 1935 C.D. 11, 45	i3 O.G. 213.					
Disposition of Claims							
4) Claim(s) <u>1-29</u> is/are pending in the application.							
4a) Of the above claim(s) is/are withdray	vn from consideration.						
5) Claim(s) is/are allowed.	•						
6)⊠ Claim(s) <u>1-29</u> is/are rejected.							
7) Claim(s) is/are objected to.							
8) Claim(s) are subject to restriction and/or	r election requirement.						
Application Papers							
9)☐ The specification is objected to by the Examine	r.						
10)⊠ The drawing(s) filed on <u>14 November 2003</u> is/a	re: a)⊠ accepted or b)□ object	ed to by the Exan	niner.				
Applicant may not request that any objection to the							
Replacement drawing sheet(s) including the correct							
11)☐ The oath or declaration is objected to by the Ex	aminer. Note the attached Office	Action or form P	10-152.				
Priority under 35 U.S.C. § 119							
12) ☐ Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a))-(d) or (f).					
, a) ☐ All b) ☐ Some * c) ☐ None of:							
1. Certified copies of the priority documents							
	2. Certified copies of the priority documents have been received in Application No						
3. Copies of the certified copies of the priority documents have been received in this National Stage							
application from the International Bureau (PCT Rule 17.2(a)).							
* See the attached detailed Office action for a list of the certified copies not received.							
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Attachment(s) 1) Notice of References Cited (PTO-892)	4) Interview Summary	(PTO-413)					
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Da	ate					
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 11/14/03.	5) Notice of Informal P 6) Other:	Patent Application (PT	D-152)				

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DETAILED ACTION

Claim 7 is rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claim 7, "the width" lacks antecedent basis; "the die" also lacks antecedent basis.

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (a) the invention was known or used by others in this country, or patented or described in a printed publication in this or a foreign country, before the invention thereof by the applicant for a patent.
- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of

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the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claim 14, 16, 17, 18 are rejected under 35 U.S.C. 102(a or e; b) as being anticipated Tsunoi et al. or Tsukahara, respectively.

Regarding claim 14, 17, 18, Tsunoi et al. 6,482,676 teaches a device including substrate 3 incuding electrical connections 4, semiconductor die 1, including set of electrical connections 6 having first end connection are and second end connection are, the first end connection are being connected to the semiconductor die, being wider than the second end (corresponding to a distal tip and a base, wherein at least a distal portion of the first set of electrical connections narrows toward the distal tip). See column 3 line 19 to column 5 line 60; column 6 line 15 to column 8 line 22. Regarding claim 18, the resin is shown in Fig. 1F, material 9. Regarding claims 16, 17, the substantial conical is also shown in Fig. 1A-1F.

Tsukaha 6,051,093 also teaches a device including substrate 4 including electrical connections 7, semiconductor die 1, including set of electrical connections 15 having first end connection are and second end connection are, the first end connection are being connected to the semiconductor die, being wider than the second end (corresponding to a distal tip and a base, wherein at least a distal portion of the first

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set of electrical connections narrows toward the distal tip). See Figs. 6-10, 14-16, column 6 line 38 to column 7 line 60, column 9 line 40 to column 9 line 40. Regarding claim 18, the non-conductive material is shown in Fig. 14(d), material 21. Regarding the shape claimed, sukahara further show the desired shape for the bump including the substantial triangular, Figs. 6, 8a, 14(a), 15(a) of Tsukahara, element 15, and such selection of such conventional shape would have been apparent or otherwise conventional and obvious.

Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunoi et al. or Tsukahara taken with Dias.

Tsunoi et al. or Tsukahara lacks primarily the recitation of the first set of electrical connections including at least 50% copper.

Dias 6,815,831 B2 teach the bump materials can be any suitable conductive materials including copper. See column 2 lines 30-38.

It would have been obvious to one skilled in the art in practicing the above invention to have employed copper as the conductive materials since such use of such materials is conventional and advantageous as taught by Dias. It would have been obvious and would have been within the purview of one skilled in the art to have selected the suitable copper content including at least 50%.

Claim 1, 2, 4-9, 11-13, 19-26 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunoi et al. taken with Tsukahara and Dias.

Regarding claims, 1, 2, 4-7, 9, 11-13, 19-26 Tsunoi et al. 6,482,676 teaches a device including first electrical unit 3, a second electrical unit 1, first set of electrical

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connections extending from second electrical unit 1, each of the first set of electrical connections including a distal tip and a base, wherein at least a distal portion of the first set of electrical connections narrows toward the distal tip. See column 3 line 19 to column 5 line 60; column 6 line 15 to column 8 line 22. Tsunoi et al. lacks primarily the recitation of the first set of electrical connections including at least 50% copper. Tsukaha 6,051,093 also teaches a device including substrate 4 including electrical connections 7, semiconductor die 1, including set of electrical connections 15 having first end connection are and second end connection are, the first end connection are being connected to the semiconductor die, being wider than the second end (corresponding to a distal tip and a base, wherein at least a distal portion of the first set of electrical connections narrows toward the distal tip). See Figs. 6-10, 14-16, column 6 line 38 to column 7 line 60, column 9 line 40 to column 9 line 40.

The references lack primarily the recitation of copper material.

Dias teach the bump materials can be any suitable conductive materials including copper. See column 2 lines 30-38.

It would have been obvious to one skilled in the art in practicing Tsunoi et al. or Tsukahara to have employed copper as the conductive materials since such use of such materials is conventional and advantageous as taught by Dias. It would have been obvious and would have been within the purview of one skilled in the art to have selected the suitable copper content including at least 50% as in claim 1, or at least 80% as in claim 4. Regarding claim 5, the suitable melting point would follow the suitable copper alloy employed. The appropriate shapes in claims 6, 9 and 11 would

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have been obvious and apparent as shown in Fig. 1-3, particularly Fig. 1B, 2 in Tsunoi et al. and as shown in Figs. 6, 8a, 14(a), 15(a) of Tsukahara, element 15. Regarding claims 12 the inclusion of the nonconductive material resin is well known as shown in Fig. 1F, material 9, in Tsunoi et al. Regarding claims 8, 22, 23, in addition to the shapes shown in Tsunoi et al. above, Tsukahara further show the desired shape for the bump including the substantial triangular, Fig. 6, 814b, 9B, and such selection of such conventional shape would have been conventional and obvious.

Claim 3 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunoi et al. taken with Tsukahara and Dias as applied to claims 1, 2, 4-9, 11-13, 19-26 above, and further in view of Hsieh et al.

Regarding the alternative of the first electric al unit is a semiconductor chip,

Hsieh shows the formation of bumps 210 joined into pads 306 on chip 300. See column

3 line 1 to column 4 line 25.

It would have been obvious to have employed the first unit as a semiconductor die since such is conventional as evidenced by Hsieh et al. wherein flip chip bonding can be effected by forming metal bumps on flip-chip substrate using simpler processing.

Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunoi et al. taken with Tsukahara and Dias as applied to claims 1, 2, 4-9, 11-13, 19-26 above, and further in view of Shiota et al. or Liu et al.

The references as applied above do not recite pentagon shape. Shiota et al. recite the pentagon shape, column 9 lines 25-40, wherein the reliability of electrical

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connection can be obtained. Liu et al. 2002/0109227 A1 also evidences the conventional of pentagon bumps. See [0031], claim 9.

It would have been obvious to one skilled in the art in practicing the above invention to have employed such conventional shape is conventional and advantageous to improve reliability as evidenced by Shiota et al. or Liu et al.

Claims 27-29 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunoi et al. taken with Tsukahara and further in view of Dias and Hua.

Tsunoi et al., Tsukahara and Dias are applied as above and do not recite the processor and the DRAM in claim 27.

Hua, 2004/0262778, teaches the application into processor 500 and DRAMs. See [0042], Figs. 1-5, [0012]-[0030], [0039-0044]. wherein the provision of bumps 130 on chip 110 joined to joint 140 and pad 150 on substrate 160 is also shown.

It would have been obvious to one skilled in the art to have applied the above structures into processor and DRAMs device since such application is conventional and obvious for forming such devices employing the connections in question as evidenced by Hua.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to examiner Quach whose telephone number is (571) 272-1717. The examiner can normally be reached on M - F from 8:30 AM to 4:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor Nathan Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (571) 272-1562.

Tuan Quach
Primary Examiner